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April 2007

# FDG8842CZ

# Complementary PowerTrench® MOSFET

Q1:30V,0.75A,0.4 $\Omega$ ; Q2:-25V,-0.41A,1.1 $\Omega$ 

#### **Features**

Q1: N-Channel

■ Max  $r_{DS(on)}$  = 0.4 $\Omega$  at  $V_{GS}$  = 4.5V,  $I_D$  = 0.75A

■ Max  $r_{DS(on)} = 0.5\Omega$  at  $V_{GS} = 2.7V$ ,  $I_D = 0.67A$ 

Q2: P-Channel

■ Max  $r_{DS(on)} = 1.1\Omega$  at  $V_{GS} = -4.5V$ ,  $I_D = -0.41A$ 

■ Max  $r_{DS(on)} = 1.5\Omega$  at  $V_{GS} = -2.7V$ ,  $I_D = -0.25A$ 

■ Very low level gate drive requirements allowing direct operation in 3V circuits(V<sub>GS(th)</sub> <1.5V)

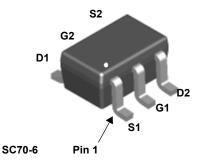
■ Very small package outline SC70-6

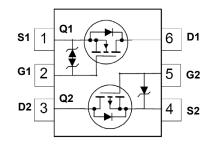
■ RoHS Compliant



#### **General Description**

These N & P-Channel logic level enhancement mode field effect transistors are produced using Fairchild's proprietary, high cell density, DMOS technology. This very high density process is especially tailored to minimize on-state resistance. This device has been designed especially for low voltage applications as a replacement for bipolar digital transistors and small signal MOSFETs. Since bias resistors are not required, this dual digital FET can replace several different digital transistors, with different bias resistor values.





# MOSFET Maximum Ratings T<sub>A</sub> = 25°C unless otherwise noted

Symbol	Parameter	_	Q1	Q2	Units
$V_{DS}$	Drain to Source Voltage		30	-25	V
$V_{GS}$	Gate to Source Voltage		±12	-8	V
	Drain Current -Continuous		0.75	-0.41	^
ID	-Pulsed		2.2	-1.2	Α
0	Power Dissipation for Single Operation (Note 1a)		0.36		10/
$P_{D}$		(Note 1b)	(b) 0.30		W
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range –55 to +150		+150	°C	

#### **Thermal Characteristics**

$R_{\theta JA}$	Thermal Resistance, Junction to Ambient Single operation	(Note 1a)	350	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient Single operation	(Note 1b)	415	C/VV

### **Package Marking and Ordering Information**

Device Marking	Device	Reel Size	Tape Width	Quantity
.42	FDG8842CZ	7"	8mm	3000 units

# **Electrical Characteristics** $T_J = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Off Chara	acteristics						
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250\mu A, V_{GS} = 0V$ $I_D = -250\mu A, V_{GS} = 0V$	Q1 Q2	30 –25			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, referenced to 25°C $I_D$ = -250 $\mu$ A, referenced to 25°C	Q1 Q2		25 –21		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 24V, V_{GS} = 0V$ $V_{DS} = -20V, V_{GS} = 0V$	Q1 Q2			1 –1	μА
I <sub>GSS</sub>	Gate to Source Leakage Current	$V_{GS} = \pm 12V, V_{DS} = 0V$ $V_{GS} = -8V, V_{DS} = 0V$	Q1 Q2			±10 –100	μA nA

### **On Characteristics**

V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$ $V_{GS} = V_{DS}, I_D = -250 \mu A$	Q1 Q2	0.65 -0.65	1.0 -0.8	1.5 –1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D$ = 250μA, referenced to 25°C $I_D$ = -250μA, referenced to 25°C	Q1 Q2		-3.0 1.8		mV/°C
_	Static Drain to Source On	$V_{GS} = 4.5V$ , $I_D = 0.75A$ $V_{GS} = 2.7V$ , $I_D = 0.67A$ $V_{GS} = 4.5V$ , $I_D = 0.75A$ , $T_J = 125^{\circ}C$	Q1		0.25 0.29 0.36	0.4 0.5 0.6	
r <sub>DS(on)</sub> Resistance	Resistance	$V_{GS} = -4.5V$ , $I_D = -0.41A$ $V_{GS} = -2.7V$ , $I_D = -0.25A$ $V_{GS} = -4.5V$ , $I_D = -0.41A$ , $T_J = 125^{\circ}C$	Q2		0.87 1.20 1.22	1.1 1.5 1.9	Ω
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = 5V$ , $I_D = 0.75A$ $V_{DS} = -5V$ , $I_D = -0.41A$	Q1 Q2		3 8		S

### **Dynamic Characteristics**

C	Input Capacitance	Q1	Q1	90	120	рF
C <sub>iss</sub>	при Сараспапсе	$V_{DS} = 10V, V_{GS} = 0V, f = 1MHZ$	Q2	70	100	ρг
<u></u>	Output Canacitanas	Q2	Q1	20	30	ъГ
Coss	Output Capacitance	$V_{DS} = -10V$ , $V_{GS} = 0V$ , $f = 1MHZ$	Q2	30	40	pF
<u></u>	Dayeras Transfer Canacitanes		Q1	15	25	ъГ
Crss	Reverse Transfer Capacitance		Q2	15	25	pF

### **Switching Characteristics** (note 2)

t <sub>d(on)</sub>	Turn-On Delay Time	Q1	Q1 Q2	4 6	10 12	ns
t <sub>r</sub>	Rise Time	$V_{DD} = 5V, I_{D} = 0.5A,$ $V_{GS} = 4.5V, R_{GEN} = 6\Omega$ $Q2$	Q1 Q2	1 16	10 29	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{DD} = -5V, I_{D} = -0.5A,$ $V_{GS} = -4.5V, R_{GEN} = 6\Omega$	Q1 Q2	9 35	18 56	ns
t <sub>f</sub>	Fall Time	- VGS 4.0V,1 (GEN 032	Q1 Q2	1 40	10 64	ns
Qg	Total Gate Charge	Q1	Q1 Q2	1.03 1.20	1.44 1.68	nC
Q <sub>gs</sub>	Gate to Source Charge	$V_{GS}$ =4.5V, $V_{DD}$ = 5V, $I_{D}$ = 0.75A Q2	Q1 Q2	0.29 0.31		nC
$Q_{gd}$	Gate to Drain "Miller" Charge	$V_{GS} = -4.5V$ , $V_{DD} = -5V$ , $I_{D} = -0.41A$	Q1 Q2	0.17 0.22		nC

# **Electrical Characteristics** $T_J = 25$ °C unless otherwise noted

Symbol Parameter Test Conditions Type Min Typ Max Units
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## **Drain-Source Diode Characteristics and Maximum Ratings**

I <sub>S</sub>	Maximum Continuous Drain-Source Diode	Forward Current		Q1 Q2		0.3 -0.3	Α
$V_{SD}$	Source to Drain Diode Forward Voltage V	$t_{GS} = 0V, I_S = 0.3A$ $t_{GS} = 0V, I_S = -0.3A$	(Note 2) (Note 2)	Q1 Q2	0.76 -0.84	1.2 –1.2	V

#### Notes

1. R<sub>BJA</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R<sub>BJC</sub> is guaranteed by design while R<sub>BJA</sub> is determined by the user's board design.



a.  $350^{\circ}$  C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper .



b.  $415^{\circ}\text{C/W}$  when mounted on a minimum pad of 2 oz copper.

Scale 1:1 on letter size paper.

2. Pulse Test: Pulse Width < 300μs, Duty cycle < 2.0%.

## Typical Characteristics (Q1 N-Channel)T<sub>J</sub> = 25°C unless otherwise noted

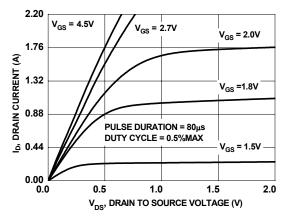


Figure 1. On-Region Characteristics

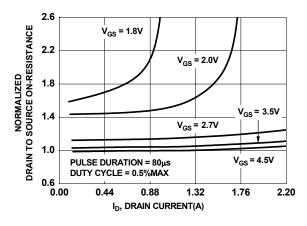


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

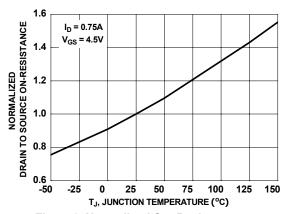


Figure 3. Normalized On-Resistance vs Junction Temperature

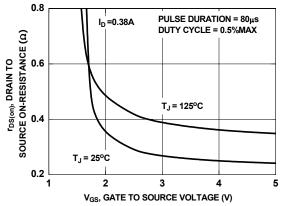


Figure 4. On-Resistance vs Gate to Source Voltage

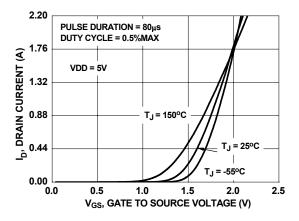


Figure 5. Transfer Characteristics

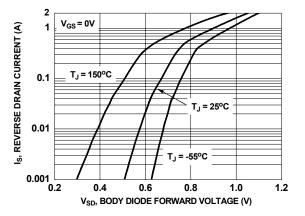


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

## Typical Characteristics (Q1 N-Channel)T<sub>J</sub> = 25°C unless otherwise noted

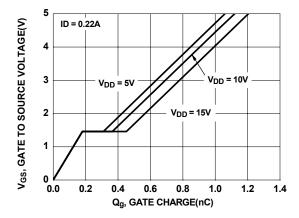


Figure 7. Gate Charge Characteristics

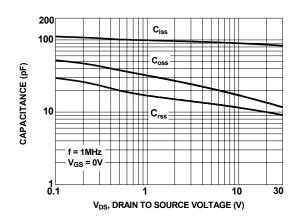
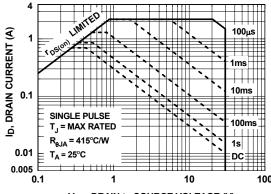


Figure 8. Capacitance vs Drain to Source Voltage



V<sub>DS</sub>, DRAIN to SOURCE VOLTAGE (V) Figure 9. Forward Bias Safe Operating Area

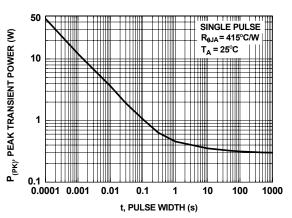


Figure 10. Single Pulse Maximum Power Dissipation

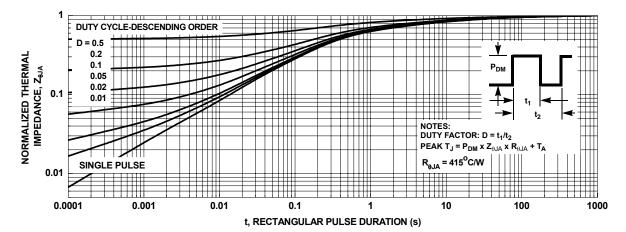


Figure 11. Transient Thermal Response Curve

### Typical Characteristics (Q2 P-Channel)T<sub>J</sub> = 25°C unless otherwise noted

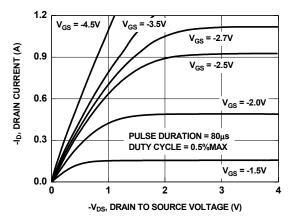


Figure 13. On Region Characteristics

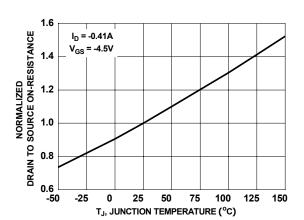


Figure 15. Normalized On Resistance vs Junction Temperature

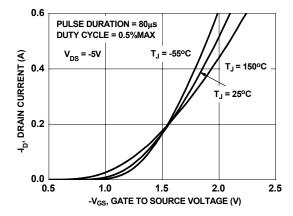


Figure 17. Transfer Characteristics

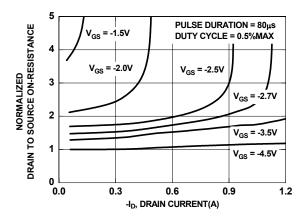


Figure 14. Normalized on-Resistance vs Drain Current and Gate Voltage

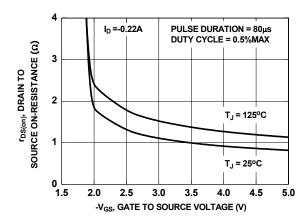


Figure 16. On-Resistance vs Gate to Source Voltage

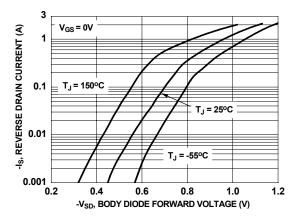


Figure 18. Source to Drain Diode Forward Voltage vs Source Current

# Typical Characteristics(Q2 P-Channel) T<sub>J</sub> = 25°C unless otherwise noted

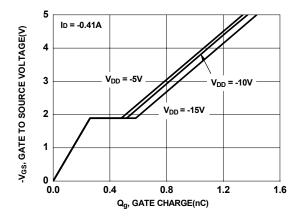


Figure 19. Gate Charge Characteristics

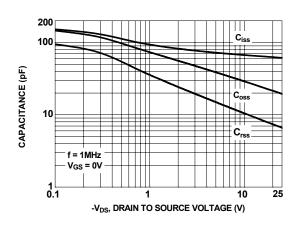


Figure 20. Capacitance vs Drain to Source Voltage

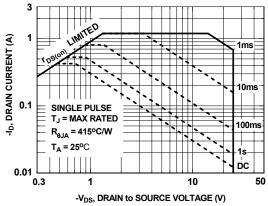


Figure 21. Forward Bias Safe Operating Area

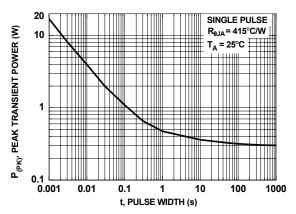


Figure 22. Single Pulse Maximum Power Dissipation

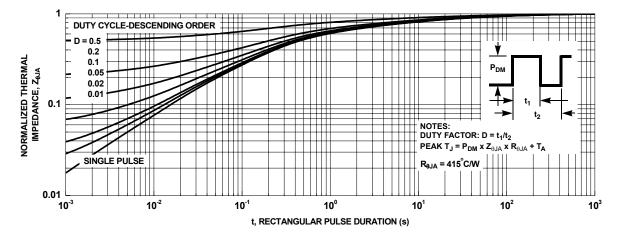


Figure 23. Transient Thermal Response Curve





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